NI 5412 Specifications

NI PXI/PCI-5412 14-Bit 100 MS/s Arbitrary Waveform Generator

Unless otherwise noted, the following conditions were used for each specification:

- Interpolation set to maximum allowed factor for a given sample rate.
- Signals terminated with 50 Ω .
- Low-Gain Amplifier Path set to 2 V_{pk-pk} , and High-Gain Amplifier Path set to 12 V_{pk-pk} .
- Sample clock set to 100 MS/s.

Typical values are representative of an average unit operating at room temperature. Specifications are subject to change without notice. For the most recent NI 5412 specifications, visit ni.com/manuals.

To access all the NI 5412 documentation, including the *NI Signal Generators Getting Started Guide*, which contains functional descriptions of the NI 5412 signals, navigate to **Start»Programs»National Instruments»NI-FGEN»Documentation**.



Caution Hot Surface Allow the NI 5412 to cool before removing it from the chassis to reduce risk of burns. Use caution when handling because recently used NI 5412 devices may exceed safe handling temperatures.

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CH 0

(Channel O Analog Output, Front Panel Connector)

Table 1.

Specification		Comments					
Number of Channels	1	_					
Connector	SMB (jac	k)			_		
Output Voltage	Character	ristics					
Output Paths	full-scale 50 Ω load the High-	The software-selectable Main Output Path setting provides full-scale voltages from 12.00 V_{pk-pk} to 5.64 mV_{pk-pk} into a 50 Ω load. NI-FGEN uses either the Low-Gain Amplifier or the High-Gain Amplifier when the Main Output Path is selected, depending on the Gain attribute.					
DAC Resolution	14 bits		_				
Amplitude and	Offset						
Amplitude			Amplitu	$de(V_{pk-pk})$	1. Amplitude		
Range	Path	Load	Minimum Value	Maximum Value	values assume the full scale		
	Low- Gain	50 Ω	0.00564	2.00	of the DAC is utilized. If an		
	Amplifier	$1 \text{ k}\Omega$	0.0107	3.81	amplitude smaller than		
		Open	0.0113	4.00	the minimum value is		
	High- Gain	50Ω	0.0338	12.0	desired, then waveforms less		
	Amplifier	1 kΩ	0.0644	22.9	than full scale of the DAC can		
		Open	0.0676	24.0	be used.		
Amplitude Resolution	3 digits	_					
Offset Range			mplitude Range with itude Range.	h increments	_		

Table 1. (Continued)

Specification		Comments					
Maximum Output Voltage							
Maximum	Path	The Maximum Output Voltage					
Output Voltage	Low-	50 Ω					
	Gain Amplifier	1 kΩ	±1.905	determined by the Amplitude			
		Open	±2.000	Range and the Offset Range.			
	High- Gain	50 Ω	±6.000	Offset Range.			
	Amplifier	1 kΩ	±11.43				
		Open	±12.00				
Accuracy	1						
DC Accuracy	±0.2% of (within ±	Calibrated for high impedance					
	±0.4% of (0 °C to 5	load.					
AC Amplitude Accuracy	±1.0% of	50 kHz sine wave.					
Output Charac	teristics						
Output Impedance	50 Ω or 7	_					
Output Coupling	DC	DC					
Output Enable	Software- CH 0 Out equal to t	_					
Maximum Output Overload	The CH (without s	_					
Waveform Summing	similar pa	aths—spec	apports waveform summing among cifically, the outputs of multiple NI 5412 an be connected directly together.	_			

Table 1. (Continued)

Specification	Va	Comments					
Frequency and	Frequency and Transient Response						
Bandwidth	20 MHz		-3 dB				
Digital Interpolation Filter	Software-selectable Finite In Available interpolation factor	_					
Passband	Low-Gain and High	_					
Flatness	±1.0 dB from						
Pulse	P	All values are					
Response	Low-Gain Amplifier High-Gain Amplifier		typical. Measured with a				
Rise/Fall Time	<20 ns	<20 ns	1 m RG-223				
Aberration	<5%	<5%	cable.				

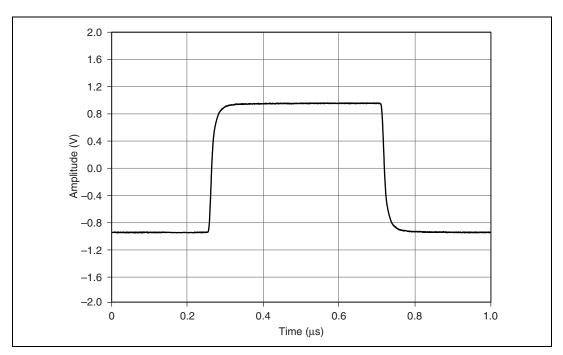


Figure 1. Pulse Response, Low-Gain Amplifier Path 50 Ω Load

Table 1. (Continued)

Specification	Va	Comments				
Suggested Maximum Frequencies for Common Functions						
Function	Pa	ath	_			
	Low-Gain Amplifier	High-Gain Amplifier				
Sine	20 MHz	20 MHz				
Square	5 MHz	5 MHz				
Ramp	1 MHz	1 MHz				
Triangle	1 MHz	1 MHz				
Spectral Chara	cteristics					
Spurious-Free Dynamic Range (SFDR) without	Path		Amplitude -1 dBFS. Measured from DC to 50 MHz. SFDR without			
Harmonics	Low-Gain Amplifier	High-Gain Amplifier	harmonics at low			
1 MHz	-70 dBc	-70 dBc	amplitudes is limited by a			
10 MHz	-65 dBc	–65 dBc	-148 dBm/Hz noise floor. All			
20 MHz	-60 dBc	-60 dBc	values are typical.			
0 °C to 40 °C	Pa	ath	Amplitude			
Total Harmonic Distortion (THD)	Low-Gain Amplifier	High-Gain Amplifier	-1 dBFS. Includes the 2 nd through the 6 th harmonic. All			
1 MHz	-59 dBc	-51 dBc	values are typical.			
10 MHz	-52 dBc	-40 dBc				
20 MHz	–45 dBc	-37 dBc				

Table 1. (Continued)

Specification	Value					Comments	
Spectral Characteristics (Continued)							
Average Noise Density		-	litude nge	Avera	ge Noise D	ensity	Average Noise Density at small
	Path	V _{pk-pk}	dBm	$\frac{\text{nV}}{\sqrt{\text{Hz}}}$	dBm/Hz	dBFS/ Hz	amplitudes is limited by a –148 dBm/Hz
	Low-Gain	2	10	45	-134	-144	noise floor.
	High- Gain	12	25.6	251	-119	-145	

Sample Clock

Table 2.

Specification	Value	Comments
Sources	 Internal, Divide-by-N (N≥1) Internal, DDS-based, High-Resolution External, CLK IN (SMB front panel connector) NI PXI-5412: External, PXI Star trigger (backplane connector) 	Refer to the Onboard Clock section for more information about Internal Clock Sources.
	5. NI PXI-5412: External, PXI_Trig<07> (backplane connector) NI PCI-5412: External, RTSI<07>	

Table 2. (Continued)

Specification		Comments						
Sample Rate Rat	Sample Rate Range and Resolution							
Sample Clock Source	Sample Rate R	ange	Sample	e Rate Resolution	_			
Divide-by-N	23.84 S/s to 100	MS/s		to (100 MS/s) / <i>N</i> 4,194,304)				
High- Resolution	10 S/s to 100 M	MS/s	1.06 µHz	Z				
CLK IN	200 kS/s to 105	MS/s		on determined by				
NI PXI-5412 PXI Star Trigger	10 S/s to 105 M	MS/s Externa		clock source. Sample Clock duty erance 40% to 60%.				
NI PXI-5412 PXI_Trig<07>	10 S/s to 20 M	o 20 MS/s						
NI PCI-5412 RTSI<07>	10 S/s to 20 MS/s		1S/s					
Effective Sample	e Rate							
	Sample Rate (MS/s)	_	olation ctor	Effective Sample Rate	Effective Sample Rate =			
	10 S/s to 105 MS/s	1 (Off)	10 S/s to 105 MS/s	(Interpolation Factor)*(Sample Rate)			
	12.5 MS/s to 105 MS/s		2	25 MS/s to 210 MS/s				
	10 MS/s to 100 MS/s		4	40 MS/s to 400 MS/s				
	10 MS/s to 50 MS/s	8		80 MS/s to 400 MS/s				
Sample Clock Delay Range and Resolution								
Sample Clock Source	Delay Adjustmen	Delay Adjustment ent Range Resolution		_				
Divide-by-N	±1 sample clock	lock period <10 ps						
High- Resolution	±1 sample clock	period		ample Clock eriod/16,384				

Table 2. (Continued)

Specification			Comments					
System Phase No	System Phase Noise and Jitter (10 MHz Carrier)							
Sample Clock Source	System Phase Noise Density (dBc/Hz) Offset System Output Jitter (Integrated from			1. High- Resolution specifications vary with				
	100 Hz	1 kHz	10 kHz	100 Hz to 100 kHz)	Sample Rate.			
NI PXI-5412	-100	-118	-120	<6 ps rms	2. All values are			
NI PCI-5412	-90	-110	-120	<7 ps rms	typical.			
External Sample Clock Input Jitter Tolerance	Cycle-Cy Period Ji	_						
Sample Clock Ex	xporting							
Exported Sample Clock Destinations	1. PFI<01> (SMB front panel connectors) 2. NI PXI-5412: PXI_Trig<06> (backplane connector) NI PCI-5412: RTSI<06>				Exported Sample Clocks can be divided by integer K ($1 \le K \le 4,194,304$).			
Exported Sample Clock Destinations	Maxii							
PFI<01>]						
NI PXI-5412 PXI_Trig<06>	20 MHz —							
NI PCI-5412 RTSI<06>		20 MHz		_				

Onboard Clock (Internal VCXO)

Table 3.

Specification	Value	Comments
Clock Source	Internal sample clocks can either be locked to a Reference Clock using a phase-locked loop or be derived from the onboard VCXO frequency reference.	_
Frequency Accuracy	±25 ppm	_

Phase-Locked Loop (PLL) Reference Clock

Table 4.

Specification	Value	Comments
Sources	NI PXI-5412—PXI_CLK10 (backplane connector) NI PCI-5412—RTSI_7 (RTSI_CLK) CLK IN (SMB front panel connector)	The PLL Reference Clock provides the reference frequency for the phase-locked loop.
Frequency Accuracy	When using the PLL, the Frequency Accuracy of the NI 5412 is solely dependent on the Frequency Accuracy of the PLL Reference Clock Source.	_
Lock Time	≤ 200 ms.	_
Frequency Range	5 MHz to 20 MHz in increments of 1 MHz. Default of 10 MHz. The PLL Reference Clock Frequency has to be accurate to ±50 ppm.	_
Duty Cycle Range	40% to 60%	_
Exported PLL Reference Clock Destinations	 PFI<01> (SMB front panel connectors) NI PXI-5412—PXI_Trig<06> (backplane connector) NI PCI-5412—RTSI<06> 	_

CLK IN

(Sample Clock and Reference Clock Input, Front Panel Connector)

Table 5.

Specification	Value	Comments
Connector	SMB (jack)	_
Direction	Input	_
Destinations	1. Sample Clock	_
	2. PLL Reference Clock	
Frequency Range	1 MHz to 105 MHz (Sample Clock destination and sine waves)	_
	200 kHz to 105 MHz (Sample Clock destination and square waves)	
	5 MHz to 20 MHz (PLL Reference Clock destination)	
Input Voltage Range	Sine wave: $0.65~V_{pk-pk}$ to $2.8~V_{pk-pk}$ into $50~\Omega$ (0 dBm to +13 dBm)	_
	Square wave: $0.2 V_{pk-pk}$ to $2.8 V_{pk-pk}$ into 50Ω	
Maximum Input Overload	±10 V	_
Input Impedance	50 Ω	_
Input Coupling	AC	_

PFI 0 and PFI 1

(Programmable Function Interface, Front Panel Connectors)

Table 6.

Specification	Value	Comments
Connectors	Two SMB (jack)	_
Direction	Bi-directional	_
Frequency Range	DC to 105 MHz	_
As an Input (Tr	igger)	
Destinations	Start Trigger	_
Maximum Input Overload	-2 V to +7 V	_
V _{IH}	2.0 V	
V _{IL}	0.8 V	
Input Impedance	1 kΩ	
As an Output (I	Event)	
Sources	1. Sample Clock divided by integer K ($1 \le K \le 4,194,304$)	_
	2. Sample Clock Timebase (100 MHz) divided by integer M ($2 \le M \le 4,194,304$)	
	3. PLL Reference Clock	
	4. Marker	
	5. Exported Start Trigger (Out Start Trigger)	
Output Impedance	50 Ω	_
Maximum Output Overload	-2 V to +7 V	_

Table 6. (Continued)

Specification	Value	Comments
V _{OH}	Minimum: 2.9 V (open load), 1.4 V (50 Ω load)	Output drivers are
$V_{ m OL}$	Maximum: 0.2 V (open load), 0.2 V (50 Ω load)	+3.3 V TTL compatible. Measured with a 1 m cable.
Rise/Fall Time (20% to 80%)	≤2.0 ns	Load of 10 pF.

Start Trigger

Table 7.

Specification	Value	Comments
Sources	1. PFI<01> (SMB front panel connectors)	_
	2. NI PXI-5412—PXI_Trig<07> (backplane connector) NI PCI-5412—RTSI<07>	
	3. NI PXI-5412—PXI Star trigger (backplane connector)	
	4. Software (use function call)	
	5. Immediate (does not wait for a trigger). Default.	
Modes	1. Single	_
	2. Continuous	
	3. Stepped	
	4. Burst	
Edge Detection	Rising	_
Minimum Pulse Width	25 ns. Refer to t _{s1} at NI Signal Generators Help»Devices» NI 5412»NI 	_

Table 7. (Continued)

, ,			
Specification	Va	lue	Comments
Delay from	Interpolation Factor	Typical Delay	Refer to t _{s2} at
Start Trigger to CH 0 Analog Output	Digital Interpolation Filter disabled.	43 Sample Clock Periods + 110 ns	NI Signal Generators Help»Devices»
1	2	57 Sample Clock Periods + 110 ns	NI 5412» NI <bus>-5412»</bus>
	4	63 Sample Clock Periods + 110 ns	Triggering» Trigger Timing.
	8	64 Sample Clock Periods + 110 ns	
Trigger Export	ing		
Exported Trigger Destinations	A signal used as a trigger can be routed out to any destination listed in the <i>Destinations</i> specification of Table 8.		_
Exported Trigger Delay	65 ns (typical). Refer to t _{s3} at NI Signal Generators Help» Devices»NI 5412»NI bus>-5412»Triggering»Trigger Timing .		_
Exported Trigger Pulse Width	>150 ns. Refer to t _{s4} at NI Signal Generators Help» Devices»NI 5412»NI bus>-5412»Triggering»Trigger Timing .		_

Markers

Table 8.

Specification	Va	lue	Comments
Destinations	PFI<01> (SMB front panel connectors) NI PXI-5412—PXI_Trig<06> (backplane connector)		_
Quantity	NI PCI-5412—RTSI<06> One Marker per Segment.		_
Quantum	Marker position must be placed at an integer multiple of four samples.		_
Width	>150 ns. Refer to t _{m2} at NI Signal Generators Help» Devices»NI 5412»NI Seneration»Marker Events.		_
Skew	With Respect to Analog Destination Output		Refer to t _{m1} at NI Signal
	PFI<01> ±2 Sample Clock Periods		Generators Help»Devices»
	NI PXI-5412 PXI_Trig<06> NI PCI-5412 RTSI<06>	±2 Sample Clock Periods	NI 5412» NI <bus>-5412» Waveform Generation» Marker Events.</bus>

Waveform and Instruction Memory Utilization

Table 9.

Specification		Value		Comments
Memory Usage	The NI 5412 uses the Synchronization and Memory Core (SMC) technology in which waveforms and instructions share onboard memory. Parameters, such as number of segments in sequence list, maximum number of waveforms in memory, and number of samples available for waveform storage, are flexible and user defined.			_
Onboard Memory Size	8 MB standard: 8,388,608 bytes	32 MB option: 33,554,432 bytes	256 MB option: 268,435,456 bytes	_
Output Modes	Arbitrary Waveforr	m mode and Arbitrary	y Sequence mode	_
Arbitrary Waveform Mode		In Arbitrary Waveform mode, a single waveform is selected from the set of waveforms stored in onboard memory and generated.		
Arbitrary Sequence Mode	In Arbitrary Sequence mode, a sequence directs the NI 5412 to generate a set of waveforms in a specific order. Elements of the sequence are referred to as segments. Each segment is associated with a set of instructions. The instructions identify which waveform is selected from the set of waveforms in memory, how many loops (iterations) of the waveform are generated, and at which sample in the waveform a marker output signal is sent.			_
Minimum Waveform Size	Trigger Mode	Arbitrary Waveform Mode	Arbitrary Sequence Mode	The Minimum Waveform Size
(Samples)	Single	16	16	is sample rate dependent in
	Continuous	16	96 @ >50 MS/s	Arbitrary
			32 @ ≤50 MS/s	Sequence Mode.
	Stepped	32	96 @ >50 MS/s	
			32 @ ≤50 MS/s	
	Burst	16	512 @ >50 MS/s	
			256 @ ≤50 MS/s	

Table 9. (Continued)

Specification	Value			Comments
Loop Count	1 to 16,777,215. Burst trigger: Unlin	1 to 16,777,215. Burst trigger: Unlimited		
Quantum	Waveform size mus	st be an integer multi	ple of four samples.	_
Memory Limits				
	8 MB Standard	32 MB Option	256 MB Option	All trigger modes
Arbitrary Waveform Mode, Maximum Waveform Memory	4,194,176 Samples	16,777,088 Samples	134,217,600 Samples	except where noted.
Arbitrary Sequence Mode, Maximum Waveform Memory	4,194,120 Samples	16,777,008 Samples	134,217,520 Samples	Condition: One or two segments in a sequence.
Arbitrary Sequence Mode, Maximum Waveforms	65,000 Burst trigger: 8,000	262,000 Burst trigger: 32,000	2,097,000 Burst trigger: 262,000	Condition: One or two segments in a sequence.
Arbitrary Sequence Mode, Maximum Segments in a Sequence	104,000 Burst trigger: 65,000	418,000 Burst trigger: 262,000	3,354,000 Burst trigger: 2,090,000	Condition: Waveform memory is <4,000 samples.

Calibration

Table 10.

Specification	Value	Comments
Self-Calibration	An onboard, 24-bit ADC and precision voltage reference are used to calibrate the DC gain and offset. The self-calibration is initiated by the user through the software and takes approximately 75 seconds to complete.	_
External Calibration	The External Calibration calibrates the VCXO, voltage reference, DC gain, and offset. Appropriate constants are stored in nonvolatile memory.	_
Calibration Interval	Specifications valid within 2 years of External Calibration.	_
Warm-up Time	15 minutes	_

Power

Table 11.

Specification	Normal Operation	Overload Operation	Comments
Total Power	22 W	26 W	Typical. Overload operation occurs when CH 0 is shorted to ground.

Software

Table 12.

Specification	Value	Comments
Driver Software	NI-FGEN 2.3 or later version. NI-FGEN is an IVI-compliant driver that allows you to configure, control, and calibrate the NI 5412. NI-FGEN provides application programming interfaces for many development environments.	_
Application Software	NI-FGEN provides programming interfaces for the following application development environments:	_
	• LabVIEW	
	LabWindows [™] /CVI [™]	
	Measurement Studio	
	Microsoft Visual C++ .NET	
	Microsoft Visual C/C++	
	Microsoft Visual Basic	
Soft Front Panel/ Interactive	The FGEN Soft Front Panel 2.3 or later supports interactive control of the NI 5412. The FGEN Soft Front Panel is included on the NI-FGEN driver CD.	_
Configuration	Measurement & Automation Explorer (MAX) also provides interactive configuration and test tools for the NI 5412. MAX is also included on the NI-FGEN CD.	

Environment

NI PXI-5412 Environment



Note To ensure that the NI PXI-5412 cools effectively, follow the guidelines in the *Maintain Forced-Air Cooling Note to Users* included in the NI 5412 kit. The NI PXI-5412 is intended for indoor use only.

Table 13.

Specifications	Value	Comments
Operating	0 °C to +55 °C in all NI PXI chassis except the following:	_
Temperature	0 °C to +45 °C when installed in an NI PXI-101x or NI PXI-1000B chassis.	
	Meets IEC-60068-2-1 and IEC-60068-2-2.	
Storage Temperature	-25 °C to +85 °C. Meets IEC-60068-2-1 and IEC-60068-2-2.	_
Operating Relative Humidity	10% to 90%, noncondensing. Meets IEC-60068-2-56.	
Storage Relative Humidity	5% to 95%, noncondensing. Meets IEC-60068-2-56.	_
Operating Shock	30 g, half-sine, 11 ms pulse. Meets IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.	Spectral and jitter specifications could degrade.
Storage Shock	50 g, half-sine, 11 ms pulse. Meets IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.	_
Operating Vibration	5 Hz to 500 Hz, 0.31 g _{rms} . Meets IEC-60068-2-64.	Spectral and jitter specifications could degrade.
Storage Vibration	5 Hz to 500 Hz, 2.46 g _{rms} . Meets IEC-60068-2-64. Test profile exceeds requirements of MIL-PRF-28800F, Class B.	_
Altitude	2,000 m maximum (at 25 °C ambient temperature)	_
Pollution Degree	2	_

NI PCI-5412 Environment



Note To ensure that the NI PCI-5412 cools effectively, follow the guidelines in the *Maintain Forced-Air Cooling Note to Users* included in the NI 5412 kit. Also, to maximize airflow and extend the life of the device, leave any adjacent PCI slots empty. The NI PCI-5412 is intended for indoor use only.

Table 14.

Specifications	Value	Comments
Operating Temperature	0 °C to +45 °C. Meets IEC-60068-2-1 and IEC-60068-2-2.	_
Storage Temperature	-25 °C to +85 °C. Meets IEC-60068-2-1 and IEC-60068-2-2.	_
Operating Relative Humidity	10% to 90%, noncondensing. Meets IEC-60068-2-56.	
Storage Relative Humidity	5% to 95%, noncondensing. Meets IEC-60068-2-56.	_
Storage Shock	50 g, half-sine, 11 ms pulse. Meets IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.	_
Storage Vibration	5 Hz to 500 Hz, 2.46 g _{rms} . Meets IEC-60068-2-64. Test profile exceeds requirements of MIL-PRF-28800F, Class B.	_
Altitude	2,000 m maximum (at 25 °C ambient temperature)	_
Pollution Degree	2	_

Safety, Electromagnetic Compatibility, and CE Compliance

Table 15.

Specification	Value	Comments
Safety	The NI 5412 meets the requirements of the following standards for safety and electrical equipment for measurement, control, and laboratory use: • IEC 61010-1, EN 61010-1 • UL 61010-1 • CAN/CSA C22.2 No. 61010-1	For UL and other safety certifications, refer to the product label or to ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.
Emissions	EN 55011 Class A at 10 m FCC Part 15A above 1 GHz	_
Immunity	EN 61326:1997 + A2:2001, Table 1 Up to 4 mVpp noise (about –44 dBm) may be present on the output during the conducted immunity test. Use of the product at levels below –44 dBm will result in self-recoverable errors. Good screening (shielding) techniques must be employed throughout the user's data acquisition system.	

Table 15. (Continued)

Specification	Value	Comments		
EMC/EMI	CE, C-Tick, and FCC Part 15 (Class A) Compliant	_		
	Notes:			
	This device is not intended for, and is restricted from, use in residential areas.			
	2. For EMC compliance, operate this device with shielded cabling.			
	3. When connected to other test objects, this product may cause radio interference. If this occurs, you may be required to take adequate measures to reduce the interference.			
This product meets the essential requirements of applicable European Directives as amended for CE marking, as follows:				
Low-Voltage Directive (safety)	73/23/EEC	_		
Electromagnetic Compatibility Directive (EMC)	89/336/EEC	_		

Note: Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Table 16.

Specification	Value		Comments		
	NI PXI-5412	NI PCI-5412			
Dimensions	Single 3U PXI slot. CompactPCI compatible.	$34.07 \times 10.67 \times 2.03$ cm $(13.4 \times 4.20 \times 0.8 \text{ inches})$	_		
	$2.0 \times 13.0 \times 21.6 \text{ cm}$ (0.8 × 5.1 × 8.5 inches)				
Weight	340 g (11 oz)	480 g (17 oz)	_		
Front Panel Con	nnectors				
Label	Function(s)	Connector Type	_		
CH 0	Analog Output	SMB (jack)			
CLK IN	Sample clock input and PLL reference clock input.	SMB (jack)			
PFI 0	Marker output, trigger input, sample clock output, exported trigger output, and PLL reference clock output.	SMB (jack)			
PFI 1	Marker output, trigger input, sample clock output, exported trigger output, and PLL reference clock output.	SMB (jack)			
NI PXI-5412 Only—Front Panel LED Indicators					
Label	Function		For more		
ACCESS LED	The ACCESS LED indicates the status of the PCI bus and the interface from the NI 5412 to the controller.		information, refer to the NI Signal Generators Help.		
ACTIVE LED	The ACTIVE LED indicates the status of the onboard generation hardware of the NI 5412.				
Included Cable					
	1 (NI part number 763541-01 Plug, RG223/U, Double Shie	_			

Where to Go for Support

The National Instruments Web site is your complete resource for technical support. At ni.com/support you have access to everything from troubleshooting and application development self-help resources to email and phone assistance from NI Application Engineers.

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